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Transactions of Nonferrous Metals Society of China

www.tnmsc.cn



Trans. Nonferrous Met. Soc. China 25(2015) 2009–2017

## Growth behavior of CVD diamond in microchannels of Cu template

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Received 10 March 2014; accepted 26 June 2014

**Abstract:** Deposition of diamond inside the trenches or microchannels by chemical vapor deposition (CVD) is limited by the diffusion efficiency of important radical species for diamond growth (H, CH<sub>3</sub>) and the pore depth of the substrate template. By ultrasonic seeding with nanodiamond suspension, three-dimensional (3D) penetration structure diamond was successfully deposited in cylindrical microchannels of Cu template by hot-filament chemical vapor deposition. Micro-Raman spectroscopy and scanning electron microscopy (SEM) were used to characterize diamond film and the effects of microchannel depth on the morphology, grain size and growth rate of diamond film were comprehensively investigated. The results show that diamond quality and growth rate sharply decrease with the increase of the depth of cylindrical microchannel. Individual diamond grain develops gradually from faceted crystals into micrometer cluster, and finally to ballas-type nanocrystalline one. In order to modify the rapid decrease of diamond quality and growth rate, a new hot filament apparatus with a forced gas flow through Cu microchannels was designed. Furthermore, the growth of diamond film by new apparatus was compared with that without a forced gas flow, and the enhancement mechanism was discussed.

Key words: chemical vapor deposition; diamond; template; Cu substrate; microchannel

## **1** Introduction

Due to its extreme hardness, high electrical resistivity, wide band gap and the highest thermal conductivity, diamond is considered as an excellent candidate for micro- or nano-electromechanical systems (MEMS/NEMS) [1]. The development of chemical vapor deposition (CVD) technique for diamond widens its applications. Prototypes of MEMS/NEMS made of CVD diamond have been used for certain application areas such as gears, motors, burrs, electron emission tips and scanning probe microscopy (SPM) tips [2-4]. MALAVE et al [5] prepared diamond cantilevers for scanning probe microscopy measurements by using a silicon template. Their radius of curvature is about 20 nm. Diamond tips doped with about 1% boron (carrier concentrations  $\geq 10^{21}$ cm<sup>-3</sup>) show a resistivity of  $10^{-3} \Omega$ /cm. ADAMSCHIK et al [6] presented a diamond micro reactor system. It consists of reaction chambers with removable bottom and integrates micro dosage elements allowing the

ejection and mixture of two different fluids onto the removable bottom substrate. CVD diamond which is chemically inert ensures the reactions with superior precision and reliability. In their experiments, the diamond micro reactor system combined with a specifically designed chemistry for the DNA-synthesis enables the parallel production of DNA-chain-clusters with individual sequence arranged in an array (DNA-chip).

However, three-dimensional (3D) diamond devices prepared by using molding technique require deposition of diamond from the vapor phase inside the trenches or microchannels. Under those conditions, diamond growth is limited by the diffusion efficiency of the important radical species (H,  $CH_3$ ) for diamond growth. For the same composition of feed gas, gas chemistry will vary along with the depth due to surface recombination and the different transport of gas-phase radical species inside microchannels, which finally affect the growth of crystalline diamond films compared with non-diamond carbon. Preliminary results of our pertinent studies show

Foundation item: Project (21271188) supported by the Nature Science Foundation of China

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that the process window for diamond deposition in microchannels is very narrow [7]. The adjustment of the process parameters including pressure, flow, composition of the feed gas and the substrate temperature is not very effective. For example, gas pressure serves as opposite effects by influencing the concentrations and the mean free paths of radical species, simultaneously.

Then, in this work, Cu templates with an open pored structure were used as substrates. Micro-Raman spectroscopy and scanning electron microscopy were used to characterize the diamond film and the effects of infiltration depths on the morphology, grain size and growth rate of diamond film were comprehensively investigated. Furthermore, a new hot filament apparatus with a forced transport of radical species through Cu microchannels was designed to overcome the dilemma of the narrow process window. The growth of diamond film was compared with that without a forced gas flow.

## 2 Experimental

#### 2.1 Diamond deposition and substrate pretreatment

Cu templates full of cylindrical microchannels with 1 mm in diameter were used as substrates. Those microchannels are vertical to template surfaces, which allow neglecting tortuosity. Prior to deposition, Cu templates were first dipped in 0.5% hydrochloric acid (HCl) for 5 min to remove surface oxide layer and machining burr, and then rinsed in de-ionized water to remove residual HCl. As a seeding pretreatment, the substrates were ultrasonically treated in an aqueous suspension of detonation nanodiamond powders (particle size ~10 nm) for 30 min, followed by a rinsing in acetone for 5 min.

A standard hot-filament chemical vapor deposition

(HF-CVD) system was used to deposit diamond films. Details of the experimental set-up can be found elsewhere [8]. The process gas was activated by using a spiral coil filament (tungsten wire, diameter 0.38 mm), suspended between two molybdenum rods. Filament temperatures ( $T_f$ ) were measured by optical pyrometer. Substrate temperatures ( $T_s$ ) were controlled by  $T_f$  and filament-substrate distance ( $d_f$ ), and measured by K-type thermocouples attached to the substrate surface. Table 1 shows the process parameters in detail. For realizing a forced gas flow through template microchannels, we built a special substrate holder with integrated vacuum connection (Fig. 1).

**Table 1** Experimental parameters used for diamond deposition

Parameter	Value
Filament temperature, $T_{\rm f}$ C	2200±100
Substrate temperature, $T_{\rm s}$ /°C	750±30
Filament-substrate distance, $d_{\rm f}$ /mm	8±1
Pressure/kPa	2.0
<i>V</i> (CH <sub>4</sub> )/ <i>V</i> (H <sub>2</sub> )	2:98
Deposition time /h	48

#### 2.2 Characterization

The morphologies of the deposited diamond were characterized by field emission scanning electron microscope (FE-SEM, FEI Sirion 200). Microstructural analyses of diamond film were performed by micro-Raman spectroscopy (Lab Raman RH800) in room temperature using an  $Ar^+$  ion laser (488 nm) at the range of 800–2200 cm<sup>-1</sup>. Prior to Raman characterization of the deposited film, Raman system was calibrated by using a Si sample.



Fig. 1 Schematic drawing of experimental setup without (a) and with (b) forced gas flow through substrate microchannels

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## **3 Results and discussion**

#### 3.1 Diamond nucleation with nanodiamond seeding

Copper, like diamond, has a cubic crystal structure, and its lattice mismatch with diamond is only 1.14%. However, diamond cannot nucleate on copper through forming carbide, nor can it be dissolved in copper. A thin graphite layer must be produced as an intermediate at the early stage, which results in low density of diamond nucleation  $(5 \times 10^4 - 1 \times 10^6 \text{ cm}^{-2})$  and long induction time (>10 h) [9]. Low nucleation density produces discontinuous diamond film. In order to enhance diamond nucleation on Cu substrate, a number of surface pretreatment methods have been developed, including diamond scratching, carbon implanting and biasedenhanced nucleation [10]. But those methods are practical for plane substrate instead of cylindrical microchannels.

As Cu templates were ultrasonically treated in an aqueous suspension of detonation nanodiamond powders, a large number of nanodiamonds could adhere to the inner wall of cylindrical microchannels via van der Waals interactions [11]. These induced seeds will act as starting points for the nucleation of diamond from the gas phase. Figures 2(a) and (b) show the cross-sectional SEM micrographs of 3D penetration structure of diamond deposited in cylindrical microchannels without or with a forced gas flow through substrate microchannels, respectively. It is visible that both of diamond films develop continuously from the upper surface of cylindrical microchannels to the bottom. The thicknesses are approximately 1.06 µm. Those SEM results give evidences of the successful enhancement nucleation by nanodiamond seeding. While, in our experiments, the nucleation density by nanoseeding is at least boosted to the order of  $10^{11}$  cm<sup>-2</sup> since the value is the lower limit for the growth of continuous diamond film [12].

Because of the non-carbon affinity of copper, diamond film directly depositing on Cu substrates always suffers from poor adhesion. Therefore, continuous films would catastrophically fail (crack and delaminate) when taking them out from the depositing chamber, although continuous films could grow on Cu substrates. The debonding phenomenon is also obvious in both SEM images.

## 3.2 Diamond growth without forced gas flow through substrate microchannels

Figure 3 shows the morphologies of diamond film deposited in cylindrical microchannels without a forced gas flow through substrate microchannels. The surface SEM micrographs were collected in steps of 200 µm starting from the top to the bottom. It can be seen that



Fig. 2 3D penetration structures of diamond deposited in CVD system by adopting without (a) and with (b) forced gas flow through substrate microchannels

diamond grains deposited at the microchannel mouth are well-faceted and the average size of those crystals is 13.7 µm (Fg. 3(a)). No preferred orientation is observed. While, a large number of smaller diamond grains appear at the neighborhood of larger ones. The grain size of the small grains is ranged from 2 to 4 µm. Previous work shows that smaller grains are formed as a consequence of the enhanced secondary nucleation effect [7]. The film in morphology of diamond cylindrical microchannels shows that the amount of big grains decreases and that of secondarily nucleated crystals adequately develops (Fig. 3(b)). The size distribution becomes uniform. It is widely accepted that secondary nucleation is correlated with deposition temperature [13]. When the substrate is closer to the hot filament, the higher temperature causes excessively fast growth of some diamond crystals, and eventually immerses the others. A large number of grain boundaries among big crystals are generated and ultimately induce secondary nucleation.

Figure 3(c) shows the morphology of diamond film at deeper position. Compared with Fig. 3(a), the secondary nucleation is lower and its grain size is more uniform. The average size of diamond crystals deceases to 6.8 µm. As the SEM image apparently illustrated, the quality of diamond crystal decreases. There are outstanding reentrant grooves at crystal edges. BÜHLER and PRIOR et al [14] demonstrated that those defect generation depended on the growth parameter  $\alpha$ ( $\alpha = \sqrt{3}v_{100} / v_{111}$ , where  $v_{100}$  and  $v_{111}$  are the growth



**Fig. 3** Morphologies of diamond films deposited in Cu microchannels without forced gas flow along depth of  $0 \mu m$  (a), 200  $\mu m$  (b), 400  $\mu m$  (c), 600  $\mu m$  (d) and 800  $\mu m$  (e)

velocities of the (100) surface and the (111) surface, respectively). Those reentrant grooves between twin boundaries will develop between the (111) facets for  $\alpha$ <1.5 and the (100) facets for  $\alpha$ >1.5.

When the depth of cylindrical microchannels further increases, the diamond film is still continuous (Fig. 3(d)). No cave defect is observed. However, the facets of diamond grains disappear obviously. The crystalline grains are entirely refined. Individual diamond crystal develops into micrometer cluster. Those deviations show a larger degree of decline of diamond quality. Figure 3(e) presents the morphology of diamond film at the greatest depth of cylindrical microchannels, which is close to the bottom. Diamond crystals now completely become ballas-type nanocrystalline diamond.

Putting together the morphologies of diamond films along the depth of cylindrical microchannels in Fig. 3, we are able to find out that 1) 3D penetration structure of diamond has developed continuously from the top surface of cylindrical microchannels to the bottom, and 2) diamond quality gradually reduces with the increase of the depth of cylindrical microchannels. Faceted diamond crystals gradually develop into micrometer cluster, and finally into ballas-type nanocrystalline diamond. Figure 3(d) presents a transition state from micrometer crystals to the nanometers ones.

Figure 4 shows the Raman spectra collected in steps of 150  $\mu m$  from the microchannel top to the bottom. As



Fig. 4 Raman spectra of diamond films deposited in Cu microchannel without forced gas flow through substrate microchannels

centered at 1333 cm<sup>-1</sup>, while the Raman peak at 1365 cm<sup>-1</sup> and 1570 cm<sup>-1</sup> are corresponding to the so-called D-band and G-band of graphite, respectively. When the microchannel depth is less than 500 µm, the diamond peaks are all stronger than non-diamond peaks. Since the Raman signal is 50 times more sensitive to non-diamond carbon than that to crystalline diamond for the laser wavelength used in our experiments [15], the Raman results show that diamond film deposited in the microchannel still has high percentage of sp<sup>3</sup> carbon which corresponds to diamond phase to maximum depth of 500 µm. While intensity of non-diamond phase peaks becomes stronger with the increase of microchannel depth, and it achieves the maxima at the depth of  $500 \ \mu m$ . At depth greater than 500 µm, the peaks referring to diamond phase and non-diamond phase both become very weak, which indicates that the deposited film is of poor quality in this depth range. It is noted that the thickness of diamond film has certain influence on its Raman scattering intensity [16]. Apparently, the change of diamond quality along the depth is in agreement with the results of SEM.

the results shown in Fig. 4, the diamond peaks are





Fig. 5 Morphologies of diamond films deposited in Cu microchannels with forced gas flow along depth of 0  $\mu$ m (a), 200  $\mu$ m (b), 400  $\mu$ m (c), 600  $\mu$ m (d) and 800  $\mu$ m (e)

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grains size becomes more uniform (Fig. 5(b)). Diamond crystals are still well-faceted, but the average size decreases to  $9.5 \,\mu$ m.

With the increase of microchannel depth, diamond crystals are mostly refined except for few big ones (Fig. 5(c)). The average size of all crystal grains is 7.5  $\mu$ m. Secondary nucleation is less obvious. Interestingly, a new growth defect is presented in Fig. 5(c) (indicated with white arrow). Excrescences are found on the {100} in-faces. According to a growth model proposed by SCHWARZ et al [18], the observed growth defect is primarily caused by the gas phase conditions during the CVD process. This result implies that the change of gas chemistry in cylindrical microchannels is caused by a forced gas flow.

When the depth of cylindrical microchannel further increases, faceted faces become indistinct, which reveals that the crystallinity decreases (Fig. 5(d)). But the grain size shows minor difference compared with Fig. 5(c). Figure 5(e) shows the morphology of diamond film deposited at the deeper position of cylindrical microchannel. As the SEM image demonstrated, diamond film is still continuous. However, crystal grains now completely change into ballas-type nanocrystalline ones.

As like to diamond film deposited in cylindrical microchannels without a forced gas flow (Fig. 3), we are also able to find out the same reduction of diamond quality with increasing the depth of cylindrical microchannels from the SEM micrographs in Fig. 5. Faceted crystals gradually develop into defect ones, and finally into ballas-type nanocrystalline diamond. Figure 5(d) presents a transition state developing from micrometer crystals to nanometers ones.

Figure 6 shows the Raman spectra collected in steps of 150  $\mu$ m from the microchannel top to the bottom. As shown in Fig. 6, the sharp peaks at 1331 cm<sup>-1</sup> and the broad peaks at approximately 1580 cm<sup>-1</sup> are assigned to the characteristic peaks of crystalline diamond and the G-band of graphite, respectively. When the microchannel depth is less than 650  $\mu$ m, the diamond peaks are all stronger than the non-diamond peaks. Regarding that the sp<sup>2</sup>-bonded graphite has much higher Raman scattering efficiency than sp<sup>3</sup>-bonded diamond [15], diamond film deposited in cylindrical microchannel with the depth less than 650  $\mu$ m obviously has high percentage of diamond phases.

With the increase of microchannel depth, the peak heights (intensity) of crystalline diamond have no apparent decrease, but its full-width-half-maximum (FWHM) of diamond peak gradually broadens. The width of characteristic peak indicates that diamond quality decreases and its crystalline grains are refined, which is in agreement with SEM results (Fig. 5). Besides, the peak intensities of non-diamond phases become stronger with the increase of microchannel depth. Finally, once the depth is larger than 650  $\mu$ m, the peaks of diamond phases and non-diamond phases both become very weak. Compared with Fig. 4, the relationship between diamond quality and microchannel depth is fairly regular in Fig. 6.



Fig. 6 Raman spectra of diamond films deposited in Cu microchannel with forced gas flow through substrate microchannels

#### 3.4 Influence of forced flow through Cu microchannel

In a hot filament apparatus, atomic H created by thermal dissociation of H<sub>2</sub> plays an important role in CVD diamond process. On the one hand, atomic hydrogen drives the inter-conversion between  $C_1$  (CH<sub>x</sub>) and  $C_2$  ( $C_2H_v$ ) species both via the families of radical forming (so-called H-shifting) abstraction reactions and, in the cooler regions, by a sequence of third-body stabilized H addition reactions that culminate in the conversion of  $C_2H_v$  species to members of the  $CH_x$ family [19]. On the other hand, atomic hydrogen can effectively etch the sp<sup>2</sup> carbon [20]. Recently, laser probing measurements have verified that atomic hydrogen dissociated on the HF surface diffuses throughout the reactor volume. The loss of atomic hydrogen is not efficient in dilute CH<sub>4</sub>/H<sub>2</sub> gas mixtures [21]. Then, in the present work, atomic hydrogen densities in the cooler periphery of the reactor are far more excessive than those expected on the basis of local thermodynamic equilibrium.

However, diamond deposition inside a hole/ microchannel is more complex than that on a plane substrate because the probability of reaction between radical species and the wall surface of cylindrical microchannels becomes much higher than that with other gas species. For the same composition of feed gas, radical species concentrations will vary along the depth [7].

In view of the surface recombination and the

different transport rates of gas-phase radicals participating in the growth processes, the concentration of radical species  $C_k$  inside a cylindrical microchannel can be described by the following one-dimensional, reaction– diffusion equation [22]:

$$\frac{\mathrm{d}^2 C_k}{\mathrm{d}z^2} = -\frac{1}{D_{\mathrm{E},k}} \left( \frac{4}{d_t} r_{k,\mathrm{surface}} + r_{k,\mathrm{gas}} \right) \tag{1}$$

where  $r_k$  represents the reaction rates on the surface and at the gas phase,  $d_t$  is the effective microchannel diameter and  $D_{E,k}$  is the effective diffusion coefficient for radical species k through the stagnant gas phase.

Regarding of each individual elemental reaction with the appropriate rates, EATON et al [22] have resolved the concentration of the main species presented in diamond deposition by Eq. (1). Their results prove that radical species concentration is a function of the depth. Atomic hydrogen concentration decreases along the depth because of faster recombination on wall surfaces, while the concentration of activated species like CH<sub>3</sub><sup>-</sup> decreases along the depth because of shorter mean free path. Compared with other major radical species (e.g.,  $CH_x$  and  $C_2H_y$ ), the concentration of atomic hydrogen decreases faster. Therefore, this would favor fast growth of non-diamond phases at the greater depth. Actually, we did observe a gradual reduction of diamond quality and crystal size with the increase of the depth of cylindrical microchannels whether a forced gas flow through substrate microchannels was used. For an individual crystal, it gradually develops from faceted diamond to micrometer cluster, and finally to ballas-type nanocrystalline one. Those results verify that the decline of radical specie concentration along the depth exists in both growth conditions.

Comparing Fig. 5 and Fig. 6 with Fig. 3 and Fig. 4, respectively, we can find out two prominent effects brought by a forced gas flow through substrate microchannels. 1) Diamond film with medium crystallinity can be deposited at depth of up to approximately 600  $\mu$ m. While, the diamond crystallinity drastically decreases only at the depth of 400  $\mu$ m once a forced flow is not used, and 2) the reduction trend of diamond quality distinctly becomes slower.

Recently, kinetic Monte Carlo research found that the growth process of CVD diamond is mainly dominated by only two species (H' and CH<sub>3</sub>') in a hot filament deposition system [23]. The flux of CH<sub>3</sub>' to the surface governs the growth rate while the flux of atomic H' controls the rate of all surface reactions, including etch rate and mobility of adsorbed CH<sub>2</sub> species, and hence surface roughness. The role of all other hydrocarbon-bond radicals (C, CH, CH<sub>2</sub>, C<sub>2</sub>, etc.) in the overall growth process is minimal due to their negligible concentrations at the surface compared to that of CH<sub>3</sub>'. 2015

An equation is proposed to predict the growth rate G [23]:

$$G=0.285\times10^{-14}T_{\rm s}^{0.5}c({\rm CH}_x)/[1+0.3\exp(3430/T_{\rm s})+0.1\exp(-4420/T_{\rm s})c({\rm H}_2)/c({\rm H})], x=0-3$$
(2)

where  $T_s$  is the substrate temperature,  $c(CH_x)$ ,  $c(H_2)$  and c(H) are the corresponding concentrations of radical species. As described in Eq. (2), the growth rates are proportional to the concentration of  $CH_3$  when the concentration of H is stable.

According to Eqs. (1) and (2), the decline of major radical species (e.g.,  $CH_3$ ) concentrations with the increase of the depth will result in the same decrease of growth rate.

Figure 7 gives the relationship between growth rates of diamond film and the depth of cylindrical microchannels. Because diamond films delaminate naturally from Cu substrate, we can get an exact calculation of the growth rate. As shown in Fig. 7, both curves decrease with the increase of depth. This change law is anticipated by Eq. (1) and Eq. (2). For diamond growth without a forced gas flow through substrate microchannels, growth rate decreases from 1.6 µm/h at the top to 0.09  $\mu$ m/h at the bottom. When a forced gas flow is used, the corresponding values are 1.6 µm/h and 0.46 µm/h, respectively. The decrease trend of growth rate from the mouth to increasing depth is much lower. In other word, we are able to achieve a more uniform depositing thickness in microchannels with a forced gas flow through substrate microchannels.



**Fig. 7** Growth rates of diamond films along depths deposited in CVD system without or with forced gas flow through substrate microchannels

Besides, we can find that the decrease of growth rate near the microchannel mouth is more intense than that at greater depth without a forced gas flow. A bottleneck problem is resulted by a overgrowing of diamond film at the mouth because of the decrease of hydrogen and important radical species at greater depths. As a consequence, the mouth will close before the cylindrical microchannel is completely infiltrated with diamond. It is disadvantageous for the preparation of diamond/metal or diamond/ceramics by chemical vapor infiltration [24]. This effect can be alleviated by using a forced gas flow through substrate microchannels (Fig. 7).

The enhancement mechanism of diamond quality and growth rate by a forced transport of radical species through cylindrical microchannels can be attributed to two effects. On one hand, atomic hydrogen is not obviously influenced by the forced gas flow because of its high diffusion rates. While, CH<sub>3</sub> radicals have shorter mean free path, therefore, their concentration in cylindrical microchannels is much more boosted by the forced gas flow, and finally causes the increase of growth rate [21] (Fig. 7). On the other hand, by decreasing dwell time of the growth species in the microchannels by a force gas flow, a reaction to higher carbon molecules was suppressed [16]. This can also cause a higher amount of sp<sup>3</sup>-bonds in the diamond deposition (Fig. 6). Besides, a forced gas flow affords to provide atomic hydrogen with very high gas velocities. High kinetic energy results in enhanced surface mobility of these reactive species, which promotes an aggregation of the precursors and diamond growth [25]. Therefore, diamond grains are more adequately developed than those without a forced gas flow (Fig. 5).

GLASER et al [24] induced oxygen gas with a n(C)/n(O) ratio of 0.7 in a hot filament system. Because the decrease of the concentration of oxygenated radicals is not as intense as that of atomic hydrogen, oxygenated radicals etch graphite at higher rates than atomic hydrogen. They deposited diamond with medium quality at greater depths. But the addition of oxygen caused rapid decrease of growth rates. While, in our experiments, a forced gas flow through substrate microchannels does promote diamond deposition at greater depths and increase of the growth rate.

## **4** Conclusions

1) By an ultrasonic seeding with nanodiamond suspension, three-dimensional (3D) penetration structure diamond was successfully deposited in cylindrical microchannels of Cu template by hot-filament chemical vapor deposition (HF-CVD).

2) Diamond quality and crystal size both gradually decrease with the increase of cylindrical microchannels depth whether a forced gas flow through substrate microchannels is adopted. For an individual crystal, it gradually develops from faceted diamond into micrometer cluster, and finally into ballas-type nanocrystalline one.

3) A forced gas flow is beneficial to higher diamond

qualities at greater depths. Diamond film with medium crystallinity can be deposited on microchannels at depth of up to approximately 600  $\mu$ m. While, the diamond crystallinity decreased drastically when the depth was larger than 400  $\mu$ m once a forced flow was not used.

4) The enhancement of diamond quality and growth rate by adopting a forced gas flow through substrate microchannels can be attributed to the boosted concentration of  $CH_3$  radicals, decreased dwell time of the growth species and high gas velocities of atomic hydrogen.

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# 铜模板微通道内 CVD 金刚石生长行为

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**摘** 要: 主要活性基团(H, CH<sub>3</sub>)的有效扩散与基体模板孔的深度限制了沟道或通道内金刚石的沉积。通过纳米金 刚石悬浮液超声震荡加载籽晶,随后热丝化学气相沉积,在铜模板圆柱型微通道内成功制备出三维结构的金刚石 膜。分别采用微区激光拉曼光谱和扫描电子显微镜表征金刚石膜,考察微通道深度对金刚石形貌、晶粒尺寸与膜 生长速率的影响。结果显示: 金刚石膜的质量和生长速率随微通道深度的增加而急剧下降,单个金刚石晶粒由发 育完善、刻面清晰的晶粒逐渐转变为微米团簇,最后转变为球状纳米晶。为改善金刚石膜质量和提高生长速率, 设计出一种气源强制输送热丝化学气相沉积装置。此外,对比分析无气源强制输送条件下金刚石的生长,并讨论 气源强制输送的增强机理。

关键词: 化学气相沉积; 金刚石; 模板; 铜基体; 微通道

(Edited by Yun-bin HE)